(2)

OFFICE OF NAVAL RESEARCH

AD-A261 794

Contract N00014-91-J-1927

R&T Code 413v001

Technical Report No. 18

RESONANT TUNNELING THROUGH CHEMISORBED HALOGEN ATOMS ON AG(111)

by

JOACHIM HOSSICK SCHOTT AND HENRY S. WHITE

Prepared for Publication in

PHYSICAL REVIEW LETTERS



University of Minnesota

Department of Chemical Engineering and Materials Science
Minneapolis, MN 55455

March 20, 1993

Reproduction in whole or in part is permitted for any purpose of the United States Government.

This document has been approved for public release and sale; its distribution is unlimited.

98 3 24 04 I

REPORT DOCUMENTATION PAGE

Form Approved
OMB No 2724 3148

Flair: regaining our zen to invitored on or information is estimated to premate industry response including the time for reviewing instructions, indicating an expension of information. Send comments regarding this europe estimate or an information of information including this europe estimate or an information of inform

1. AGENCY USE ONLY (Leave blank)		3. REPORT TYPE AND	DOATES COVERED	
	March 20, 1993	Technical 6/	30/92 - 3/31/93	
4. TITLE AND SUBTITLE			5. FUNDING NUMBERS	
RESONANT TUNNELING THROUGH	H CHEMISORBED HALOGEN AT	TOMS ON AG(111)	N00014-91-J-1927	
6. AUTHOR(S)				
JOACHIM HOSSICK SCHOTT AN	D HENRY S. WHITE			
7 PERFORMING ORGANIZATION NAM	E(S) AND ADDRESS(ES)		8. PERFORMING ORGANIZATION	
Dept. of Chemical Engineering and Materials Science University of Minnesota			REPORT NUMBER Technical Report No. 18	
9. SPONSORING, MONITORING AGENC	Y NAME(S) AND ADDRESS(ES	,	10. SPONSORING / MONITORING	
Office of Naval Research			AGENCY REPORT NUMBER	
800 North Quincy Stree				
Arlington, VA 22217				
11. SUPPLEMENTARY NOTES				
12a. DISTRIBUTION : AVAILABILITY STA	TEMENT		12b. DISTRIBUTION CODE	
Unclassified/Unlimite	d			
one lassified, onlimited	4			
			'	
13. ABSTRACT (Maximum 200 words)	1 <u> </u>			
Tunneling spectroscop	y measurements perfor	med with a scanning	tunneling microscope	
(STM) on Ag(111) surfaces coated with a monolayer of halogen atoms (F, Cl, Br and I)				
are reported. Maxima	in the tunneling spectra	are assigned to reson	ance tunneling through	
both the occupied p-	and virtual bound state	es of the halogen ac	datoms. The observed	
		•		
minimum tunneling resistance at resonance is $\pi\hbar/e^2$ (~12.6 k Ω), in agreement with				
theoretical predictions	•			
14. SUBJECT TERMS			15. NUMBER OF PAGES	
			15	
			16. PRICE COOF	
	SECURITY CLASSIFICATION	19. SECURITY CLASSIFIE	CATION 20. LIMITATION OF ABSTRACT	
OF REPORT Unclassified	OF THIS PAGE UL	OF ABSTRACT		

Resonant Tunneling through Chemisorbed Halogen Atoms on Ag(111)

Joachim Hossick Schott and Henry S. White

Department of Chemical Engineering and Materials Science University of Minnesota Minneapolis, MN 55455

Tunneling spectroscopy measurements performed with a scanning tunneling microscope (STM) on Ag(111) surfaces coated with a monolayer of halogen atoms (F, Cl, Br and I) are reported. Maxima in the tunneling spectra are assigned to resonance tunneling through both the occupied p- and virtual bound states of the halogen adatoms. The observed minimum tunneling resistance at resonance is $\pi\hbar/e^2$ (~12.6 k Ω), in agreement with theoretical predictions.

PACS numbers: 79.80, 82.65M

Submitted to Physical Review Letters, Mar. 1993

Acces	sion For	9.	
NTIS	GRA&I	To the same of the	
DTIC	TAB	ñ	
Unara	icunced		
Junta	fication_		
By			
Distr	ibution/		
Ave1	lability	Codes	
	Avell and	/or	
Dist	Special		
, l	1		
	l I		
7			

Ever since the pioneering work of Tsu, Esaki and Chang^{1,2}, resonant tunneling has been recognized as an important mechanism of electrical transport through media containing localized electronic states. The flow of current through such systems is maximized whenever the energy of the incident electrons is closely matched to the energy of the localized electronic states. Kalmeyer and Laughlin³ have theoretically shown that the minimum resistance, R, in the energetic vicinity of a resonance is $(\pi\hbar/e^2)1/\Gamma$, where T denotes the transmission probability. The latter quantity may approach unity at resonance (see also: Landauer⁴). Consequently, regions of negative differential resistance may exist in the energy range between resolved resonances.

Current research on resonant tunneling is focussed on two-dimensional⁵ and one-dimensional⁶ semiconductor quantum well structures. However, resonant tunneling and related phenomena are also of great importance in metal-adsorbate systems, in particular in regard to photoinduced desorption of adsorbed species⁷ and electron field-emission from such systems^{8,9}. Reports of resonance tunneling phenomena observed with the scanning tunneling microscope (STM) are comparatively rare¹⁰⁻¹². A phenomenon closely related to resonant tunneling is observed in the STM when the tip and the metal form a one-atom point contact¹³⁻¹⁵. In this case, Lang¹³ has shown that the resistance R is again of the form $(\pi\hbar/e^2)A$, with the factor A beeing dependent on the indentity of the tip-atom, but of order unity.

In this report, we present strong evidence for resonant tunneling through chemisorbed halogen atoms observed using an STM, operated in air and at room temperature. The samples investigated in this study are Ag(111) surfaces coated with a complete monolayer of halogen atoms (X = F, Cl, Br and I). The spatial structures of the halogen monolayers can be atomically resolved by STM and are described in a previous report¹⁵. The halogen coating was prepared by immersing a flame annealed, (111) facetted Ag sample in a concentrated acidic halogen solution (consult ref. 16 for details).

No carbon or oxygen contaminations could be detected using Auger electron spectroscopy, even after several hours of exposure to ambient air.

Tunneling spectroscopy (TS) and microscopy experiments were performed with a modified Nanoscope II scanning tunneling microscope¹⁷, in which the tip was held at virtual ground and the bias voltage was applied to the sample. Tips were mechanically cut from flame annealed PtIr wire. In the TS experiments, the tunneling current I was measured as a function of the applied bias voltage V_b. The tunneling current I was recorded after current-voltage conversion across a 10 k Ω ± 1% resistor in series with the tip and passing the signal through a 1:1 operational amplifier (input impedance > $10^{12} \Omega$). The bias voltage was also recorded after passing the signal through a 1:1 operational amplifier. The tip was placed in the center of a surface area which was imaged before and after a sequence of I-V measurements to ensure that no surface damage occurred during I-V measurements. Before the actual measurement, a tip-sample distance, s, was established by adjusting the feed-back loop of the instrument with a programmable gapresistance, $R_{set} = V_{set}/I_{set}$. The feed-back loop was then disabled and the tunneling current was measured as a function of the applied voltage, which was a triangle shaped ramp. The voltage ramp initially proceeded towards positive voltages. Typical scan times were ~ 2 sec per full cycle.

Fig. 1 shows a typical current voltage traces obtained for a Cl-coated Ag(111) facet. We note several striking features of these I-V curves. 1) The tunneling current increases sharply above a positive sample bias threshold (Fig. 1a); for negative voltages between -0.5 V and 0 V, however, the current is virtually zero, as is evident from the current trace shown in the insert in Fig. 1b. (This latter trace was obtained with a 1 M Ω resistor in series with the tip; note the nA-current scale in the insert). 2) The curve in Fig. 1a exhibits current plateaus and/or peaks which are frequently accompanied by regions of negative differential resistance. 3) At voltages more negative than ~-1.4 V, the current

rises again sharply (Fig. 1b) and a broad peak is observed at ~-2.1V with a current level of ~ 165 μ A. 4) For high positive and high negative bias voltages (in excess of +0.5 V and -2.5 V, respectively) the tunneling current reaches the limit set by the 10 k Ω resistor (Fig. 1a and 1b). 5) At positive bias voltages, the I-V curves exhibit a pronounced hysteresis between the upward and downward voltage scans, e.g. Fig. 1a. The hysteresis is less pronounced in the negative bias voltage region (Fig. 1b).

We note that severe surface and/or tip damage often occurs upon starting the voltage ramp at values around -2V, most likely because of tip instabilities due to the extremely high current levels obtained in this bias voltage region (Fig. 1b). However, some tips reproducibly yield the features of the current trace shown in Fig. 1b without inducing damage, and the general phenomenon, i.e., the high current level at $V_b \sim -2V$, is reproducible with any tip. The I-V response in the positive region (Fig. 1a) can be reproduced numerous times with a particular tip over a particular surface area without inducing tip or surface damage, provided that the positive voltage scan limit is kept below $\sim +0.5V$. We therefore exclude mechanical tip-sample contact as the cause of the unusually high current levels measured in our experiments at positive and negative biases. We also rule out vibrationally assisted tunneling as a possible explanation since the expected inelastic contributions to the total current are much too low 18 .

To understand the I-V curves shown in Fig. 1, it is necessary to consider the potential energy contures at the Ag-halogen interface under the influence of the electric field between tip and sample. The theoretical work of Lang and Williams ¹⁹ indicates that the broadened 3p-level of the chemisorbed Cl atom lies ~2.5eV below the Fermi-energy of the metal and is therefore totally occupied (ionic adsorption). At zero bias, the potential energy contures between tip and sample may then be depicted as in Fig. 2a. For small negative values of V_b, tunneling will proceed mainly from the filled portion in the tail of the broadened 3p Cl-ion level into empty states of the tip. The expected current density is

low because of the low density of states in the tail of the 3p level, in agreement with the I-V curve shown in the insert of Fig. 1b. For more negative values of V_b, the Ag-Cl bond length increases, as shown by Bagus and Paccioni²⁰. Upon changing the Ag-Cl bond length, the Cl-3p level tracks the potential energy contour of the metal surface¹⁹. Therefore, as the ion moves away from the surface, the 3p level moves up in energy, as depicted in Fig. 2b. Thus, the available emitter density of states increases, resulting in an increase in the tunneling current, in agreement with Fig. 1b. When the center of the Cl-3p level passes the tip Fermi level, a resonance peak may be observed in the I-V spectrum, the energetic position of which is shifted upward with respect to its equilibrium position. We believe that the broad current shoulder at ~-2.1V (i.e., at approximately 1eV below the substrate Fermi-level) in the I-V curve in Fig. 1b is due to such a resonance.

For small positive bias voltages, tunneling will mainly proceed from the Fermilevel of the tip to empty states in the tail of the 3p level. Since there are virtually no such states, the current is essentially zero and the junction is blocking. At higher positive biases, electrons can now resonantly tunnel from filled tip states into empty Ag states, via virtual bound state levels in the Cl potential well, as depicted in Fig. 2c. Whenever the energy of the incident electrons matches the energy of such bound states, a peak in the I-V spectrum should occur, in qualitative agreement with the I-V curve in Fig. 1a. Following Kalmeyer and Laughlin³, the minimum resistance R at resonance should be $\pi\hbar/e^2$ (~ 12.6 k Ω). Inspection of Figs. 1a and 1b reveals that the minimum resistance observed at a resonance peak is indeed 12.6 k Ω (see also Figs. 3 and 4). Considering that with further increasing bias voltage (either positive or negative), more and more chemisorbed Cl atoms can act as a resonator for the tunneling (or field emitted) electrons, it is clear that there will be an increasing resonant background current. Therefore, the

current will be quickly limited by the $10k\Omega$ resistor upon increasing the bias voltage beyond the resonance onset.

Fig. 3 shows that the onset of the resonance current depends strongly on the tip-sample separation, which is proportional to the gap resistance $R_{set} = U_{set}/I_{set}$. For larger tip-sample separations the resonance onset occurs at higher bias voltages. This finding suggests that the resonance tunneling is very sensitive to variations in the shape of the local potential energy contures, as expected. Since a small thermal drift is always present in STM experiments, this also explains our observation that the resonance onset scatters by $\sim \pm 25 \text{mV}$ between subsequent measurements, in which all parameters were kept constant.

Similar I-V curves are also observed for Ag(111) facets coated with monolayers of other halogens (I, Br, and F). As an example, Fig. 4 shows a typical curve obtained from a F-coated sample. Again, pronounced resonance peaks are seen for moderately high positive bias voltages as in the Cl-case, and the minimum resistance at resonance is $\sim (\pi \hbar/e^2)$.

Finally, we address the hysteresis observed in the I-V curves. Goldman et. al. ²¹ have observed a similar phenomenon with semiconductor quantum well structures, which has been attributed to a charge-storage induced bistability in the quantum well^{22,23}; some of the charge which is injected into the potential well during the first half cycle of the voltage scan remains stored in the well, resulting in a shift of the resonance level energies in the second half cycle of the scan. Thus, a double valued current voltage curve is obtained. The hysteresis observed in our experiments at positive and negative biases may in part be associated with barrier fluctuations due to mechanical and thermal instabilities. However, a change in the structure of the chemisorbed layer beneath the tip, due to the local electric field (e.g., the change in the Ag-Cl bond length²⁰), may also account for the observed hysteresis.

In summary, we have described the behaviour of a resonance tunneling diode of atomic dimensions. The predominant features of the I-V behaviour are qualitatively well understood upon applying the principles of double barrier resonance tunneling 1,2,9 to the theoretical model of halogen-chemisorption on metal surfaces 19.

This work was supported by the Office of Naval Research. J.H.S. thanks the Deutsche Forschungsgemeinschaft for partial support under grant no. Sch 428/1-1.

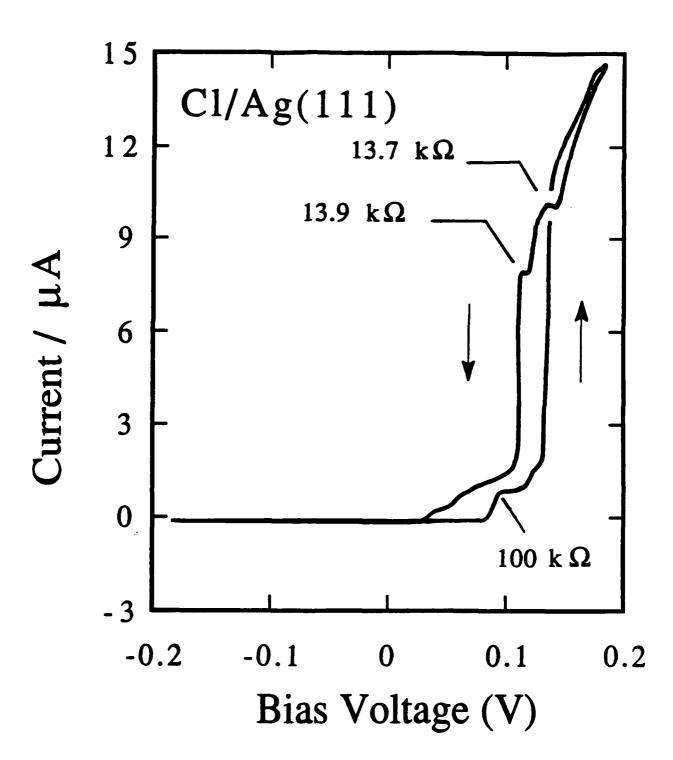
References

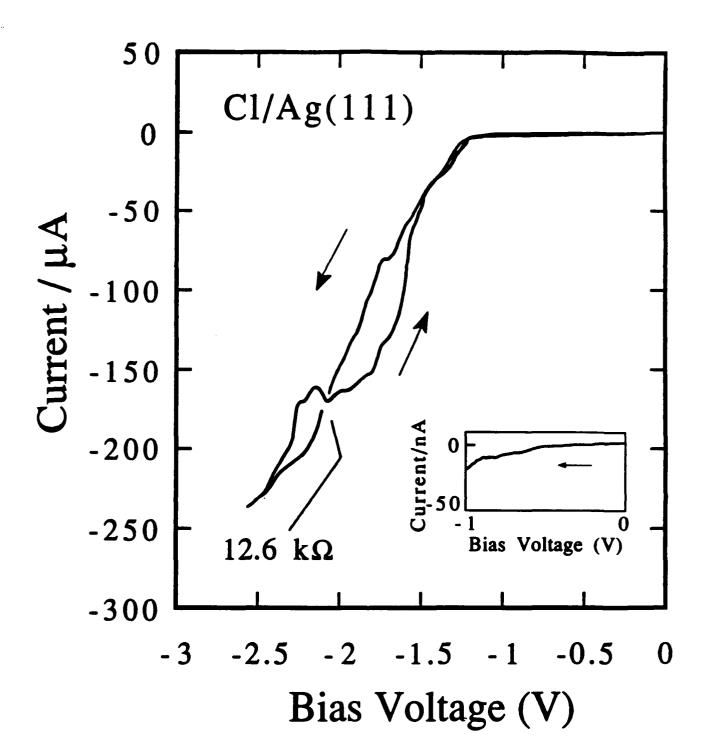
- 1) L.L. Chang, L. Esaki, R. Tsu, Appl. Phys. Lett. 24, 593 (1974)
- 2) R. Tsu, L. Esaki, Appl. Phys. Lett. 22, 562 (1973)
- 3) V. Kalmeyer, R.B. Laughlin, Phys. Rev. B 35, 9805 (1987)
- 4) R. Landauer, Z. Phys. B-Cond. Matter 68, 217 (1987)
- 5) A.B. Fowler, G.L. Timp, J.J. Wainer, R.A. Webb, Phys. Rev. Lett. 57, 138 (1986)
- 6) M.A. Reed, J.N. Randall, R.J. Agarwal, R.J. Matyi, T.M. Moore, A.E. Wetsel, Phys. Rev. Lett. 60, 535 (1988)
- 7) J.W. Gadzuk, Phys. Rev. B 44, 13466 (1991)
- 8) E.W. Plummer, R.D. Young, Phys. Rev. B 1, 2088 (1970)
- 9) J.W. Gadzuk, Phys. Rev. B 1, 2110 (1970)
- 10) G. Binnig, K.H. Frank, H. Fuchs, N. Garcia, B. Reihl, H. Rohrer, F. Salvan, A.R. Williams, Phys. Rev. Lett. 55, 991 (1985)
- 11) M.G. Youngquist, J.D. Baldeschwieler, J. Vac. Sci. Technol. B 9, 1083
 (1991)
- S. Yang, R.A. Bartynsky, G.P. Kochanski, S. Papadia, T. Fonden and M.
 Persson, Phys. Rev. Lett. 70, 849 (1993)
- 13) N.D. Lang, Phys. Rev. B 36, 8173 (1987)
- 14) J.K. Gimzewski, R. Möller, Phys. Rev. B 36, 1284 (1987)
- 15) E. Tekman, S. Ciraci, Phys. Rev. B. 43, 7145 (1991)
- 16) J. Hossick Schott, H.S. White, submitted to J. Am. Chem. Soc., Feb. 1992
- 17) Digital Instruments Inc., Nanoscope II manual
- 18) B.N.J. Persson, A. Baratoff, Phys. Rev. Lett. **59**, 339 (1987)
- 19) N.D. Lang, A.R. Williams, Phys. Rev. B 18, 616 (1978)
- 20) P.S. Bagus, G. Paccioni, Electrochim. Acta 36, 1669 (1991)

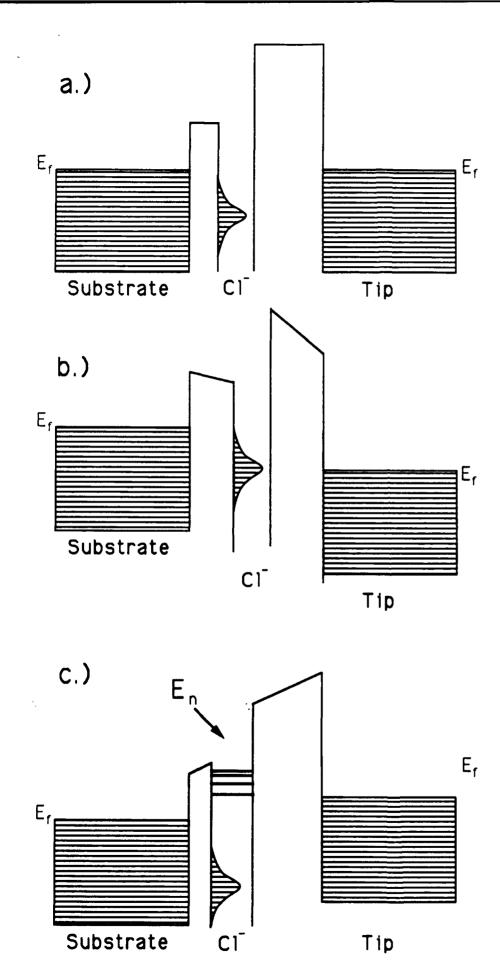
- V.J. Goldman, D.C. Tsui, J.E. Cunningham, Phys. Rev. Lett. 58, 1256 (1987); T.C.L.G. Sollner, Phys. Rev. Lett. 59, 1622 (1987); V.J. Goldman, D.C. Tsui, J.E. Cunningham, Phys. Rev. Lett. 59, 1623 (1987)
- 22) H.L. Berkowitz, R.A. Lux, J. Vac. Sci. Technol. B 4, 967 (1987)
- 23) M. Cahay, M. McLennan, S. Datta, M.S. Lundstrom, Appl. Phys. Lett. 50, 612 (1987)

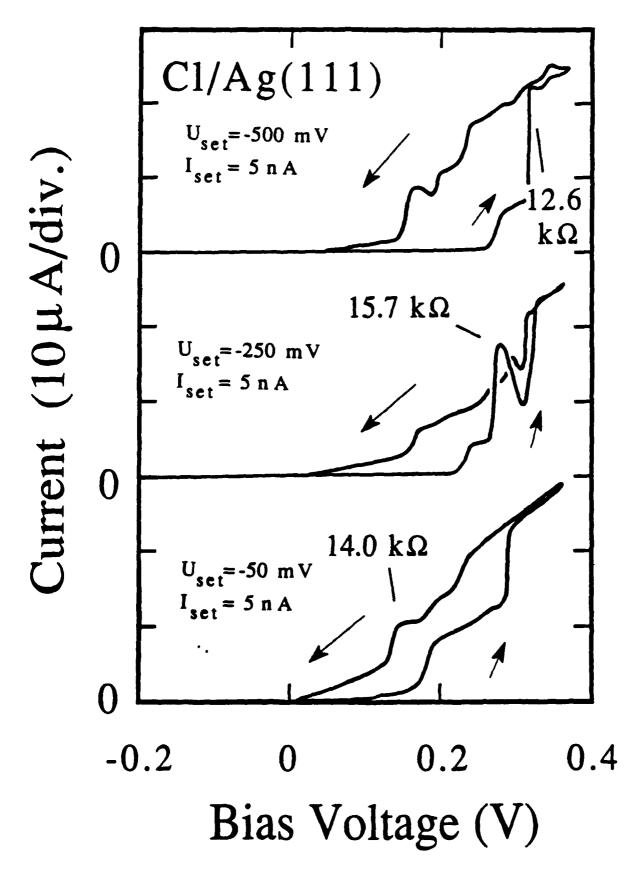
Figure Captions

- Fig. 1. Typical tunneling spectroscopy I-V traces obtained on a chlorine coated Ag(111) facet . a) Set point bias (V_b) and tunneling current (i_t): V_b = -0.07V, I_t = 11nA. b) V_b = -0.65 V, I_t = 5nA. The curve in the insert was obtained in a different experiment using a $1M\Omega$ resistor in series with the tip (same set point resistance). All other curves were obtained with a $10k\Omega$ resistor. Note the different scales.
- Fig.2. Schematic potential energy profiles in the tunnel junction. The broadened Cl-3p level is indicated by the bell-shaped distribution in the potential well between tip and sample. a) Unbiased tunnel junction. b) Negative (sample) bias. c) Positive (sample) bias. E_n scetches the virtual bound states.
- Fig.3. I-V traces obtained on a chlorine-coated Ag(111) sample for different initial set point resistances (as indicated). This sequence was obtained with the same tip over one particular surface location (negelecting small thermal drift). Time difference between subsequent measurements: ~60 sec. (see text).
- Fig.4. Typical tunneling spectroscopy current voltage trace obtained on a flourine-coated Ag(111) facet. V_b=-0.9 V, i_t=5 nA.









Francis

